IN THE CLAIMS

This listing of claims replaces all prior versions and listings of claims in the abovereferenced application.

- 1-8. (Withdrawn).
- 9. (Currently Amended) A method of forming a light emitting device, the method comprising:

forming a first semiconductor layer of a first conductivity type and having a first surface;

forming an active region over the first semiconductor layer, the active region including a second semiconductor layer, the second semiconductor layer one of a at least two quantum well layers and separated by a barrier layer, wherein one of a quantum well layer and the barrier layer is a graded layer the second semiconductor layer formed from a III-Nitride semiconductor alloy having a composition graded in a direction substantially perpendicular to the first surface of the first semiconductor layer; and

forming a third semiconductor layer of a second conductivity type over the active region.

- 10. (Currently Amended) The method of Claim 9, further comprising forming the second semiconductor layer in wherein the graded layer has a wurtzite crystal structure.
- 11. (Currently Amended) The method of Claim 9, further comprising grading the composition of the III-Nitride semiconductor alloy in the graded layer asymmetrically.
- 12. (Currently Amended) The method of Claim 9, further comprising grading the composition of the III-Nitride semiconductor alloy in the graded layer to reduce the effect of a piezoelectric field in the active region.
- 13. (Currently Amended) The method of Claim 9, further comprising grading a mole fraction of the III-Nitride semiconductor alloy in the graded layer linearly.
- 14. (Original) The method of Claim 9, wherein the III-Nitride semiconductor alloy is $In_xAl_yGa_{1-x-y}N$ with $0 \le x \le 1$, $0 \le y \le 1$, and $x + y \le 1$.
- 15. (Currently Amended) The method of Claim 14, further comprising grading the mole fraction of indium in the graded layer.
- 16. (Currently Amended) The method of Claim 14, further comprising grading the mole fraction of aluminum in the graded layer.
 - 17. (Previously Amended) The method of Claim 9, wherein the active region is



PATENT LAW GROUP LLP 2635 N. FIRST ST. SUITE 223 AN JOSE, CA 95134 (408) 382-0480 FAX (408) 382-0481 formed directly on the first semiconductor layer.

18-24. (Withdrawn).

25. (Original) A method of forming a light emitting device, the method comprising:

forming a first semiconductor layer of a first conductivity type having a first surface; forming an active region overlying the first semiconductor layer, the active region including a plurality of quantum well layers and separated by at least one barrier layer, the barrier layer formed from a III-Nitride semiconductor alloy having an indium mole fraction graded in a direction substantially perpendicular to the first surface of the first semiconductor layer; and

forming another semiconductor layer of a second conductivity type overlying the active region.

- 26. (Original) The method of Claim 25, further comprising forming the barrier layer in a wurtzite crystal structure.
- 27. (Original) The method of Claim 25, further comprising grading the indium mole fraction of the III-Nitride semiconductor alloy asymmetrically.
- 28. (Original) The method of Claim 25, further comprising grading the indium mole fraction of the III-Nitride semiconductor alloy to reduce an effect of a piezoelectric field in the active region.
- 29. (Original) The method of Claim 25, further comprising grading the indium mole fraction of the III-Nitride semiconductor alloy linearly.
- 30. (Original) The method of Claim 25, wherein the III-Nitride semiconductor alloy is $In_xAl_yGa_{1-x-y}N$ with $0 \le x \le 1$, $0 \le y \le 1$, and $x + y \le 1$.
- 31. (Original) The method of Claim 25, wherein the active region includes a plurality of barrier layers each formed from a III-Nitride semiconductor alloy having an indium mole fraction graded in a direction substantially perpendicular to the first surface of the first semiconductor layer.
- 32. (New) The method of Claim 25, further comprising grading an indium mole fraction of at least one of the plurality of quantum well layers.

B'esnela

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